

(b) (5) DPP, (b) (7)(C), (b) (7)(D)

John L. Shew

2616

SEARCHED			
Class	Subclass	Date	Examiner
370	216-218	3/17/2006	JS
	228,237		
	238.1		
	255-258		
	295,351		
370	352,355	3/20/2006	JS
	389,392		
	395.1		
	395.31		
	395.32		
	400		
	401		
	402		
	403-404		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
370	395.31	3/20/2006	JS
370	218	3/20/2006	JS
709	239	3/20/2006	JS

[illegible]

Search Notes (continued)

Application/Control No.

09/769,908

Examiner

John L. Shew

Applicant(s)/Patent under
Reexamination

MATSUHIRA ET AL.

Art Unit

2616

SEARCHED

Class	Subclass	Date	Examiner
379	221.03	3/20/2006	JS
	221.04		
709	238,239	3/20/2006	JS

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR.